## Notice of References Cited Application/Control No. 10/677,529 Examiner Tu T. Nguyen Applicant(s)/Patent Under Reexamination DESHARNAIS ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,836,285	12-2004	Lubard et al.	348/31
*	В	US-6,256,090	07-2001	Chen et al.	356/73.1
*	С	US-5,475,613	12-1995	Itoga et al.	702/39
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	7	US-			
	Κ	US-			•
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	x	

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